

**Search Notes (continued)**

Application/Control No.

10/708,720

Examiner

Sing P. Chan

Applicant(s)/Patent under  
Reexamination

KIRBY, MARK E.

Art Unit

1734

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
269	309, 311	3/2/2006	SPC
269	904	3/2/2006	SPC
52	745.21	3/2/2006	SPC
52/747.1, 747.11, 749.11		3/2/2006	SPC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

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Class	Subclass	Date	Examiner
33	371, .376, 410, 411, 518, 526	3/2/2006	SPC
33	562, 648	3/2/2006	SPC
33	809	3/2/2006	SPC
33	DIG 20	3/2/2006	SPC
156	71	3/2/2006	SPC
248	346.01	3/2/2006	SPC
248	346.05	3/2/2006	SPC
248	346.06	3/2/2006	SPC
269	309, 311	3/2/2006	SPC
269	904	3/2/2006	SPC
52	745.21	3/2/2006	SPC
52	747.1	3/2/2006	SPC
52	747.11	3/2/2006	SPC
52	749.11	3/2/2006	SPC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
33	371, 376	3/2/2006	SPC
33	410, 411	3/2/2006	SPC
33	518, 526	3/2/2006	SPC
33/562, 648, 809, DIG 20; 156/71; 248/346.01, 346.05, 346.06		3/2/2006	SPC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text and image search on EAST	3/2/2006	SPC
Inventor search on EAST and PALM on Mark Kirby	3/2/2006	SPC
PGPUB text search on EAST	3/2/2006	SPC